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566.40596X00

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): T. FUJISHIRO, et al

Serial No.: 09/941,771

Filed: August 30, 2001

For: CERTIFICATE VALIDITY AUTHENTICATION METHOD AND APPARATUS

Group: 2123

Examiner: Not assigned

**RECEIVED**

OCT 16 2002

Technology Center 2100

**INFORMATION DISCLOSURE STATEMENT  
UNDER 37 CFR §1.97 & 1.98**

Assistant Commissioner  
for Patents  
Washington, D.C. 20231

October 9, 2002

Sir:

In the matter of the above-identified application, applicants are submitting herewith a copy of a communication from a foreign patent office in a counterpart foreign application and copies of the documents listed in the attached form equivalent to Form PTO-1449 for the Examiner's consideration.

This information disclosure statement is being submitted before the mailing date of a first office action on the merits.

Each of the documents listed on the attached form equivalent to Form PTO-1449 is in the English language.

It is respectfully requested that this information disclosure statement be considered by the Examiner.

Please charge any shortage in the fees due in connection with the filing of this paper, including extension of time fees, to the deposit account of Antonelli, Terry, Stout & Kraus Deposit Account No. 01-2135 (566.40596X00) please credit any excess fees to such deposit account.

Respectfully submitted,



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**FORM PTO-1449** U.S. Department of  
Commerce (Rev. 4/92) Patent and Trademark  
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ATTY. DOCKET NO.

SERIAL NO.

**566.40596X00**

**09/941,771**

APPLICANT  
**T. FUJISHIRO, et al**

FILING DATE  
**August 30, 2002**

**GROUP  
2123**

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

# U.S. PATENT DOCUMENTS

[illegible]

## FOREIGN PATENT DOCUMENTS

[illegible]

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

		B. Schneier, "Applied Cryptograph" Applied Cryptograph, Protocols, Algorithms, and Source Code in C, New York, John Wiley & Sons, US, pp. 574-577.

**EXAMINER**

**DATE CONSIDERED**

**EXAMINER:** Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.